

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/613,899	PHILLIPS ET AL.	
	Examiner	Art Unit	
	Ren L Yan	2854	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,585,344	07-2003	Kolodziej, Ryan H.	347/19
	B	US-2004/0114127	06-2004	Todome, Tsuyoshi	355/407
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 02144351 A	06-1990	Japan	KATABUCHI et al.	B65H 07/04
	O	JP 09208086 A	08-1997	Japan	MAETANI, MASAMI	B65H 07/04
	P	JP 2002193482 A	07-2002	Japan	TSUCHIYA, RIICHI	B65H 07/02
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.